

<b>Notice of References Cited</b>	Application/Control No. 10/655,823	Applicant(s)/Patent Under Reexamination AWAKURA ET AL.	
	Examiner Dean O Takaoka	Art Unit 2817	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,462,630	10-2002	Ikedo et al.	333/181
	B	US-6,021,050	02-2000	Ehman et al.	361/793
	C	US-			
	D	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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